Electronic charge redistribution in LaAlO$_3$(001) thin films deposited at SrTiO$_3$(001) substrate: First-principles analysis and the role of stoichiometry

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We present a comprehensive first-principles study of the electronic charge redistribution in atomically sharp LaAlO$_3$/SrTiO$_3$(001) heterointerfaces of both $n$ and $p$ types allowing for nonstoichiometric composition. Using two different computational methods within the framework of the density functional theory (linear combination of atomic orbitals and plane waves) we demonstrate that conducting properties of LaAlO$_3$/SrTiO$_3$(001) heterointerfaces strongly depend on termination of LaAlO$_3$(001) surface. We argue that both the “polar catastrophe” and the polar distortion scenarios may be realized depending on the interface stoichiometry. Our calculations predict that heterointerfaces with a nonstoichiometric film—either LaO-terminated $n$ type or AlO$_2$-terminated $p$ type—may exhibit the conductivity of $n$ or $p$ type, respectively, independently of LaAlO$_3$(001) film thickness.

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I. INTRODUCTION

The discovery of conducting interfaces between two initially insulating materials—TiO$_2$-terminated (001) surface of SrTiO$_3$ (STO) substrate and LaAlO$_3$ (LAO) thin film deposited on top of it—has attracted strong scientific interest during the past few years.$^{2-6}$ The high application potential of LAO/STO heterostructures if the sample is not annealed.$^{1,16}$ The insulating nature of the conducting layer at the interface would create an electric field inside LAO increasing linearly with the distance from the interface—a “polar catastrophe.” This bulk polarization of the LAO film can be compensated (thus averting the “catastrophe”) if $0.5e$ per unit cell area is transferred from the LAO film surface onto the interface, resulting in a maximal sheet carrier density of $n = 0.5/a^2 = 3.3 \times 10^{14}$ cm$^{-2}$ (here $a = 3.90\,\text{Å}$ is the lattice constant of STO assuming epitaxial matching of the LAO film). This estimate is immune to dielectric relaxation and bond covalency/charge smearing effects$^{7}$ and, thus, provides a useful reference in the thick film limit.

For sufficiently thin films, however, the polar catastrophe may be tolerated$^{10}$ and a metal-insulator transition occurs$^{11}$ as a function of the number of epitaxial monolayers of LAO deposited. From an electrostatic perspective, in a sufficiently thin film the internal field does not develop a potential difference large enough to overcome the dielectric gap. The accumulation of oppositely charged monolayers leads to progressive band bending until the critical thickness (5 u.c. or 10 monolayers for $n$-type structures, according to experimental$^{11}$ and theoretical$^{12-14}$ evidence) is reached beyond which the chemical forces are overcome and the charge redistribution occurs. This mechanism is known as “polar distortion.”$^{4,10}$ As far as is known, $p$-type interfaces do not exhibit this mechanism, as covalent forces overwhelm electrostatic ones.

Similar electrostatic arguments may be applied to nonstoichiometric LAO/STO structures, i.e., the ones with an odd number of LAO monolayers. The LAO films in these structures possess one extra electron (or a hole for $p$-type interfaces) per unit cell area compared to the parent bulk material, thus, they should be conducting (with $n = 1/a^2 = 6.6 \times 10^{14}$ cm$^{-2}$) irrespective of the thickness or the presence of STO substrate. However, as seen from the stoichiometric example, for thin films, the competition between the semicovalent bonds and long-range electrostatics is very sensitive to the the number of monolayers deposited. The nature of the conducting layer in nonstoichiometric LAO/STO interfaces is the main subject of our $ab\,\text{initio}$ investigation.

Recent experimental reports indicate that La/Al ratio in nonstoichiometric LAO films may be controlled during epitaxial growth.$^{13,15}$ Atomically sharp interfaces are produced by molecular beam epitaxy (MBE) in which thermal energies of evaporated incident ions are low, about 0.1 eV, thus, MBE avoids intermixing of cations at the interface.$^{5,11}$ However, the vaporization process used to facilitate transfer through the vapor LAO phase does not guarantee preservation of the target stoichiometry,$^5$ which makes room for a possibility to control the film growth monolayer by monolayer. We note that for different preparation methods of LAO/STO interfaces, e.g., pulsed laser deposition (PLD), other mechanisms may give rise to conductivity. One of proposed mechanisms is formation of the high density of oxygen vacancies, which are generated in the STO substrate while depositing LAO thin film and can be responsible for increase of sheet carriers density up to $5 \times 10^{17}$ cm$^{-2}$ for PLD-grown $n$-LAO/STO interfaces if the sample is notannealed.$^{1,16}$ The insulating
behavior of $p$-LAO/STO has been also ascribed to that the holes can be trapped by two electrons located at the oxygen vacancies created in the STO substrate.\textsuperscript{17}

Yet another scenario for LAO/STO interface conductivity that may take place in PLD-prepared structures is based on the suggestion that the La/Sr cation intermixing due to ion bombardment effect (inherent in PLD and postgrowth treatment) may lead to the formation of one or two layers of metallic $\text{La}_{1-x}\text{Sr}_x\text{TiO}_3$.\textsuperscript{3,18,19} The thermodynamical stability for intermixed configurations has been recently reported.\textsuperscript{4,20}

In this paper, we aim to construct a clear picture of charge-density redistribution both in stoichiometric and nonstoichiometric interfaces of either type and LAO film thickness from 1 to 11 monolayers (0.5–5.5 u.c.). The ab initio calculation methods employed are based on the density functional theory (DFT) using a hybrid exchange-correlation functional. We contrast stoichiometric/nonstoichiometric and $n$-type/$p$-type structures utilizing identical methods and computation parameters. The B3PW functional\textsuperscript{21} used in the CRYSTAL code\textsuperscript{22} with atomic basis set (BS) contains a “hybrid” of nonlocal Hartree-Fock (HF) exchange and correlation functionals with exact nonlocal Hartree-Fock (HF) exchange. For comparison, the selected set of interface configurations has been also modeled using the Perdew-Wang generalized gradient approximation (PW91-GGA) density functional\textsuperscript{23,24} as implemented in the periodic plane-wave (PW) code VASP.\textsuperscript{25}

We find that covalent effects in nonstoichiometric films are less pronounced than in stoichiometric ones and the structures are metallic in accordance with formal charges considerations. As Ti–O bond strength exceeds Sr–O bond strength by ca. 120 kJ mol\textsuperscript{-1} (obtained considering formation enthalpies for respective oxides), in $p$-type IFs (where SrO monolayer is at the IF) we can expect covalent forces to be stronger than in $n$-type IFs. This, in its turn, leads to an approximately uniform free charge distribution throughout the film, whereas when covalent forces are weaker—as in $n$-type IFs—the free charge is forced to the edges of the LAO film (the surface and the IF), resulting in a bilayered electron gas structure.

Experimental works show that stoichiometric $p$-type interfaces exhibit no measurable conductivity,\textsuperscript{11} but annealed stoichiometric $n$-type interfaces with LAO film thickness $\geq 5$ u.c. have free electron density in the range $1–3 \times 10^{13}$ cm\textsuperscript{-2}.\textsuperscript{11} Similar densities ($2–7 \times 10^{13}$ cm\textsuperscript{-2}) are obtained from first-principles calculations\textsuperscript{12–14} (cf. $3.3 \times 10^{14}$ cm\textsuperscript{-2} predicted from electrostatic considerations).

The paper is structured as follows. Section II describes the computational details of our calculations. The main part of the paper is formed by Sec. III. In Sec. III A we give an estimate of the thermodynamic stability and discuss the electronic structure of ideal LaO- and AlO\textsubscript{2}-terminated LAO(001) surfaces. Section III B presents electronic charge distributions for $n$-LAO/STO and $p$-LAO/STO heterointerfaces and discusses their relation to the experimental and computational data available in the literature. Our conclusions are summarized in Sec. IV.

II. COMPUTATIONAL DETAILS

In this study LAO/STO heterointerfaces are modeled by means of two different methods: (i) linear combination of atomic orbitals (LCAO) within the framework of a hybrid density functional approach and (ii) PW calculations using the GGA density functional.

To perform hybrid LCAO calculations, we used the periodic CRYSTAL code,\textsuperscript{22} which employs Gaussian-type functions centered on atomic nuclei as the BSs for expansion of the crystalline orbitals. The BSs used in this study were taken from the following sources: For Sr, Ti, and O in the form of 311d1G, 411d31dG, and 8-411d1G, respectively, from Ref. 26; for Al in the form of 8-621dG from Ref. 27; and for La in the form of 311-31d3f1 from CRYSTAL’s homepage\textsuperscript{22} ($f$-type polarization Gaussian function with the exponent $\alpha = 0.475$ has been added according to prescription given in Ref. 28). For Al and O, all electrons are explicitly included. The inner core electrons of Sr and Ti are described by small-core Hay-Wadt effective pseudopotentials,\textsuperscript{29} while the nonrelativistic pseudopotential of Dolg et al.\textsuperscript{30} was adopted for La.

We employ the hybrid B3PW exchange-correlation functional\textsuperscript{21} which accurately reproduces the basic bulk and surface properties of a number of ABO\textsubscript{3} perovskite materials.\textsuperscript{26,31–33} The cutoff threshold parameters of CRYSTAL for Coulomb and exchange integrals evaluation (ITOL1–ITOL5) have been set to 7, 8, 7, 7, and 14, respectively. Calculations were considered as converged only when the total energy obtained in the self-consistency procedure differed by less than $10^{-7}$ a.u. in two successive cycles. Effective charges on atoms as well as net bond populations have been calculated according to the Mulliken population analysis.\textsuperscript{34–37}

As the second method, the periodic total-energy code VASP\textsuperscript{26} based on the use of a PW BS was applied. The cut-off energy was chosen to be 520 eV. The nonlocal GGA exchange-correlation functional Perdew-Wang-91 (PW91) was employed.\textsuperscript{23,24} Scalar relativistic projector augmented wave (PAW) pseudopotentials in our calculations contain 11 valence electrons ($5s^25p^65d^16s^2$) for La, 3 electrons ($3s^23p^1$) for Al, 10 electrons ($4s^24p^6$) for Sr, 12 electrons ($3s^23p^63d^24s^2$) for Ti, and 6 electrons ($2s^22p^4$) for O, respectively. Bader topological analysis\textsuperscript{38} was adopted to obtain net charges on atoms in VASP calculations.

In both VASP and CRYSTAL calculations the reciprocal space integration was performed by sampling the Brillouin zone with the $8 \times 8 \times 1$ Monkhorst mesh\textsuperscript{39} for all surface structures under consideration. For bulk computations we applied sampling with the $8 \times 8 \times 8$ Pack-Monkhorst mesh. Such samplings provide balanced summation in direct and reciprocal lattices.

Taking into account that STO substrate at room temperature possesses perfect cubic structure, in our study we treat both LAO and STO in their high symmetry $Pm\bar{3}m$ cubic phase. In fact, the bulk crystal structure of LAO, having space group $R\overline{3}c$ (rhombohedral) with $a_0 = 5.364$ Å and $c_0 = 13.108$ Å at room temperature,\textsuperscript{40} can be represented by a pseudocubic unit cell with $a_0 = 3.790$ Å. At 821 K the structure of LAO transforms to become cubic with $a_0 = 3.811$ Å.\textsuperscript{40} Though the heterointerface assumes the transition between two intrinsically different crystal symmetries, $Pm\bar{3}m$ the substrate and $R\overline{3}c$ in the film, whereby thin films are expected to adapt to the substrate.\textsuperscript{44}

Table I lists main bulk properties for both crystals. We note that the band gaps obtained by means of hybrid B3PW
TABLE I. Calculated equilibrium lattice constants \((a_0)\) in Å, atomic net charges \((Q_{\text{atom}})\) in e, cation–O bond populations \((P_{\text{A/B/O}})}\) in milli e, and band gaps \((\delta)\) in eV of bulk LAO and STO in their high-symmetry \(Pm\bar{3}m\) cubic phase. Shown are data obtained by means of both hybrid B3PW and standard GGA PW91 functionals. Negative bond population means atomic repulsion. Last two columns contain available experimental results for comparison.

<table>
<thead>
<tr>
<th></th>
<th>LAO (B3PW)</th>
<th>LAO (PW91)</th>
<th>STO (B3PW)</th>
<th>STO (PW91)</th>
<th>LAO STO (Expt.)</th>
<th>LAO STO (Expt.)</th>
</tr>
</thead>
<tbody>
<tr>
<td>(a_0)</td>
<td>3.802</td>
<td>3.808</td>
<td>3.910</td>
<td>3.918</td>
<td>3.811 (\pm) 3.905 (\delta)</td>
<td></td>
</tr>
<tr>
<td>(Q_{\text{La/Sr}})</td>
<td>2.43</td>
<td>2.14</td>
<td>1.87</td>
<td>1.60</td>
<td>–</td>
<td>–</td>
</tr>
<tr>
<td>(Q_{\text{Al/Ti}})</td>
<td>2.07</td>
<td>3.00</td>
<td>2.35</td>
<td>2.10</td>
<td>–</td>
<td>–</td>
</tr>
<tr>
<td>(Q_{\text{O}})</td>
<td>–1.50</td>
<td>–1.78</td>
<td>–1.41</td>
<td>–1.23</td>
<td>–</td>
<td>–</td>
</tr>
<tr>
<td>(P_{\text{La/Sr–O}})</td>
<td>4</td>
<td>–</td>
<td>–10</td>
<td>–</td>
<td>–</td>
<td>–</td>
</tr>
<tr>
<td>(P_{\text{Al/Ti–O}})</td>
<td>152</td>
<td>–</td>
<td>88</td>
<td>–</td>
<td>–</td>
<td>–</td>
</tr>
<tr>
<td>(\delta)</td>
<td>5.51</td>
<td>3.18</td>
<td>3.64</td>
<td>1.77</td>
<td>5.6 (\pm) 3.25 (\delta)</td>
<td></td>
</tr>
</tbody>
</table>

\(\alpha\) Reference 40.
\(\beta\) Reference 41.
\(\gamma\) Reference 42.
\(\delta\) Reference 43.

III. RESULTS AND DISCUSSION

A. LAO(001) surfaces

Before general discussion of LAO/STO interfaces studied here, in this subsection we provide a comprehensive description of electronic and thermodynamic properties of both LAO- and AlO\(_2\)-terminated pristine LAO(001) thin films.

1. Electronic properties

Pristine LAO(001) thin films were modeled using a symmetrical nine-monolayer slab model. Considering formal ionic charges, LAO(001) has alternating \((\text{LaO})^+\) and \((\text{AlO}_2)^-\) surface monolayers and can be either a LaO- or AlO\(_2\)-terminated surface. Both LaO and AlO\(_2\) terminations are studied. The La/Al excess ratio is 1.25 and 0.8 for LaO- and AlO\(_2\)-terminated LAO(001) films, respectively. Monolayers in LAO(001) possess a net charge, and the repeat slab unit cell has a nonzero dipole moment, and, therefore, LAO(001) is type III polar surface according to Tasker’s classification. This means that perfect and unreconstructed \((1 \times 1)\) LAO(001) surfaces considered here can be stabilized by transferring of a half an electron (or hole) from the surface to the slab body that normally results in atomic and electronic reconfiguration at the surface.

In Table II we list the changes in surface \((\text{LaO})^+\) and \((\text{AlO}_2)^-\) monolayer net charge \((\Delta Q)\) in e, and deviations of cation–O bond populations \((\Delta P_{\text{A/B/O}})}\) in milli e in the corresponding atomic monolayer relative to the bulk values (see Table I). Shown are data obtained by means of a hybrid B3PW exchange-correlation functional. Surface monolayers are numbered beginning from the center of the slab (0 means the central monolayer of the symmetrical slab unit cell).

<table>
<thead>
<tr>
<th></th>
<th>(\text{LaO terminated})</th>
<th>(\text{AlO}_2) terminated</th>
</tr>
</thead>
<tbody>
<tr>
<td>(\Delta Q)</td>
<td>(\text{LaO})</td>
<td>(\text{AlO}_2)</td>
</tr>
<tr>
<td>(\Delta P_{\text{A/B/O}})</td>
<td>(\text{LaO})</td>
<td>(\text{AlO}_2)</td>
</tr>
<tr>
<td>No.</td>
<td>ML</td>
<td>(\Delta Q)</td>
</tr>
<tr>
<td>4</td>
<td>LaO</td>
<td>–0.32</td>
</tr>
<tr>
<td>3</td>
<td>AlO(_2)</td>
<td>–0.02</td>
</tr>
<tr>
<td>2</td>
<td>LaO</td>
<td>–0.09</td>
</tr>
<tr>
<td>1</td>
<td>AlO(_2)</td>
<td>0.00</td>
</tr>
<tr>
<td>0</td>
<td>LaO</td>
<td>–0.05</td>
</tr>
</tbody>
</table>

\(\alpha\) Reference 43.
level down to valence band and, thus, reveals the existence of hole conductivity.

2. Thermodynamic stability

The thermodynamic formalism adopted in the current study to estimate the stability of both LaO- and AlO₂-terminated LAO(001) surfaces has been thoroughly described in Refs. 46 and 47 (see also references therein). The stable crystalline surface has to be in equilibrium with both LAO bulk and surrounding oxygen atmosphere, assuming that an exchange of atoms between the surface and environment is allowed. Therefore, the most stable surface has the lowest Gibbs free surface energy, defined as

$$\Omega_i(T,p) = \frac{1}{2A} \left[ E_{i,\text{lab}}^{\text{e}} - N_{i,\text{Al}} E_{\text{bulk}}^{\text{LAO}} - (N_{i,\text{La}} - N_{i,\text{Al}}) \Delta \mu_{i,\text{La}} - (N_{O} - 3N_{Al}) \Delta \mu_{O}(T,p) \right],$$

where $i$ indicates the surface terminations, $A$ the unit cell surface area, $N_i$ the number of atoms of type $i$ in the slab unit cell, $E_{i,\text{lab}}^{\text{e}}$ is the total energy of a slab with $i$ surface terminations and $E_{\text{bulk}}^{\text{LAO}}$ is the LAO total energy averaged per five-atom perovskite unit cell. $\Delta \mu_{i} = \mu_{i} - E_{i,\text{bulk}}^{\text{e}}$ (i = La, Al) are deviations of chemical potentials for metal atoms from their energy in the bulk metals. For the oxygen atom, such a deviation is considered with respect to the energy of an oxygen atom in the ground triplet state of an O₂ molecule $\Delta \mu_{O} = \mu_{O} - \frac{1}{2} E_{O}^{3}$. Because the $pV$ term ($V$ is unit cell volume) and the differences in the vibrational Gibbs free energy between the bulk solid and a corresponding slab is negligibly small, we omit these two contributions. This permits replacing the Gibbs free energies in Eq. (1) and in the following formulas with the total energies obtained from ab initio calculations.

In order to avoid the precipitation of relevant metals and oxides at LAO surface, as well as to prevent metal atoms to leave the sample, the following conditions must be satisfied:

$$0 > \Delta \mu_{\text{La}}, \quad 0 > \Delta \mu_{\text{Al}},$$

$$E_{\text{LaAlO}_3}^{f} - E_{\text{Al}_2\text{O}_3}^{f} < 2\Delta \mu_{\text{La}} + 3\Delta \mu_{O} < E_{\text{La}_2\text{O}_3}^{f},$$

where $E_{f}^{f}$ is the formation energies of material $n$ listed in Table III.

We evaluate the oxygen chemical potential $\Delta \mu_{O}(p,T)$ as a function of partial gas pressure and temperature using the standard experimental thermodynamical tables as it was done in Refs. 47 and 48. $\Delta \mu_{O}(T,P_{O})$ is the variation of oxygen chemical potential due to temperature and pressure of the surrounding oxygen atmosphere. In addition to the experimental variation, it contains a correction term $\delta \mu_{O} = 0.03 \text{ eV}$, which compensates the difference between the experimentally determined variation of the oxygen chemical potential and the reference state in current theoretical calculations (see Refs. 50 and 51 for a thorough discussion).

Based on Eqs. (1)–(3), the thermodynamic stability diagram is plotted in Fig. 2, showing the regions of stability of pristine LAO(001) surfaces with respect to precipitation of La₂O₃ and Al₂O₃ oxides. Figure 3 shows the thermodynamic stability diagram along the lines corresponding to precipitation of La₂O₃ and Al₂O₃ oxides as a function of $\Delta \mu_{O}$ related to the temperature scale at an oxygen pressure typical during LAO/STO synthesis ($P = 10^{-6}$ mbar). To make such a diagram possible, according to the prescription given in Ref. 52, we replaced $\Delta \mu_{\text{La}}$ by

$$\Delta \mu_{\text{La}} = \frac{1}{2} \left( E_{\text{La}_2\text{O}_3}^{f} - 3\Delta \mu_{O} \right),$$

which corresponds to precipitation of La₂O₃ (lines 3 in Fig. 3), and by

$$\Delta \mu_{\text{La}} = E_{\text{LaAlO}_3}^{f} - \frac{1}{2} \left( E_{\text{Al}_2\text{O}_3}^{f} - 3\Delta \mu_{O} \right),$$

which corresponds to precipitation of Al₂O₃ (lines 4 in Fig. 3). Formation energies for oxides are taken from Table III.

From the calculated thermodynamic stability diagrams we can predict that at ultrahigh vacuum (UHV) conditions typical during PLD synthesis of LAO/STO interfaces and low temperatures ($T < 550 \text{ K}$), the most stable is the AlO₂-terminated surface, while at elevated temperatures ($T > 1100 \text{ K}$) stabilizes the LAO-terminated surface. Between these temperatures, both surface terminations may coexist. Further lowering of oxygen
FIG. 2. (Color online) Thermodynamic stability diagram as a function of O and La chemical potentials built for both LaO- and AlO_2-terminated LAO(001) surfaces. Diagram contains precipitation conditions for both La and Mn metals, as well as for their trivalent oxides (La_2O_3 and Al_2O_3). The stable region is shown as a shaded area between the La_2O_3 and Al_2O_3 precipitation lines. The numbers from 1 to 4 in the circles indicate segregation lines for precipitation of 1 Al, 2 La, 3 La_2O_3, 4 Al_2O_3. The right side shows a family of oxygen chemical potentials under different conditions. The label $m$ indicates the O_2 gas partial pressure: $10^{-m}$ mbar. Red (gray) line corresponds to oxygen partial pressure $p = 0.2p_0$ as in the ambient atmosphere. Point A denotes room temperature and ambient oxygen pressure, and point B denotes typical temperature and pressure during LAO/STO(001) synthesis.

pressure shifts down these demarcated temperatures. Thus, our prediction is in good qualitative agreement with time-of-flight scattering and recoiling spectrometry (TOF-SARS), atomic force microscopy (AFM), and a photoelectron spectroscopy (PES) study performed by Rabalais and coworkers. They found that at temperatures under 423 K, the surface is exclusively terminated by an Al-O layer, while at temperatures above 523 K the surface is exclusively terminated by a La-O layer. Between 423 K and 523 K surface stoichiometry changed from AlO$_x$ to LaO$_x$ and, thus, mixed terminations were proposed. Moreover, this change was found to be fully reversible. Rabalais and coworkers suggested that the surface termination change was caused by the formation of surface oxygen vacancies at high temperature, which drives the migration of the La atom to the surface and the Al atom into the bulk. A more recent experimental study based on x-ray crystal truncation rod (CRT) analysis demonstrates that LAO(001) possesses Al-terminated structure at both room and high (670 K) temperatures with no evidence for the reversal of surface termination or for the formation of surface oxygen vacancy. Authors of Ref. 55 explain the observation of La-rich termination in ion-scattering experiments by the effect of increasing access to the lanthanum atom because of considerable surface oxygen relaxation that leads to a significant enhancement of the lanthanum atom signature. On the other hand, Marx and coworkers have observed the La-terminated LAO(001) with stoichiometry of (VLa$_4$O$_5$)$_0$--0.5, where V is the lanthanum cation vacancy, i.e., each surface La is coordinate to four surface oxygens and four oxygens in the subsurface layer. Therefore, one may conclude that the experimental analyses have been performed at various conditions and report either LaO- and AlO$_2$-terminated LAO(001) or a mixture of them, so it is not clear if surfaces reached thermodynamic equilibrium.

Ab initio thermodynamical stability diagrams previously calculated for LAO(001) show that the LaO-terminated surface is more stable with respect to the AlO$_2$-terminated one and that the LaO-terminated surface containing an oxygen vacancy is more stable than oxygen-deficient AlO$_2$-terminated LAO(001). Mixed surfaces with LaO and AlO$_2$ terminations were not predicted. In fact, our thermodynamic analysis does not support this prediction. From our point of view, the main reason for such a discrepancy may be the different computational approach, DFT within the local density approximation, used by the authors of Refs. 57 and 58. 

FIG. 3. (Color online) The thermodynamic stability diagram calculated along the La_2O_3 and Al_2O_3 precipitation lines (numbers 3 and 4 in the circles, respectively) with $\Delta \mu_{La}$ defined according to Eqs. (4) and (5). The dependence on the oxygen chemical potential is converted to the appropriate temperature scale at an oxygen pressure typical during LAO/STO(001) synthesis ($P = 10^{-6}$ mbar). The interval between points C and D correspond to temperature range where both LaO- and AlO$_2$-terminated LAO(001) surfaces are stable and may coexist.
B. LAO/STO heterointerfaces

1. Charge redistribution and electronic properties

Calculations of electronic properties of the LAO/STO(001) heterointerfaces were carried out using the symmetrically terminated slab model. The STO(001) substrate consisted of 11 atomic monolayers and could be terminated with either (TiO₂) monolayer in n-type heterostructures or with the (SrO) monolayer in p-type heterostructures. Monolayer-by-monolayer epitaxial growth then was modeled, adding a pair of respective monolayers of LAO(001) symmetrically to both sides of a substrate slab until deposited LAO(001) thin film reached thickness of up to 11 monolayers. In such way, we construct 22 heterostructures of both types and of different LAO film thicknesses to model. Note that a 11-monolayer-thick substrate and a 20-Å-thick vacuum gap used for VASP GGA calculations is enough to avoid an undesirable interaction of neighboring surfaces/interfaces and allows us to reach the equilibrium charge density redistribution in heterointerfaces under study. Due to the restrictions by imposed symmetry, in our calculations atomic positions of all the heterointerfaces under study were relaxed along the z axis.

If we consider atomic displacements, we can see that cations and anions in LAO monolayers have considerably different displacements, thus, the electric dipole moment appears and accumulates within the thin film. Stoichiometric heterointerfaces have greater displacement differences between anions and cations than nonstoichiometric ones in LAO monolayers, while the situation is diametrically opposite for the STO monolayers. As we shall see further, the dipole moment creates an electric field, and its potential strongly correlates with the distortion of the band edges (so-called polar distortion), which then gives rise to the conductivity in stoichiometric LAO/STO(001) heterointerfaces of n type.

To predict the charge redistribution in heterointerfaces, we calculated the changes of net atomic Mulliken charges in comparison with the bulk phase of the LAO and STO parent materials. These charge deviations are shown in Figs. 4(a)–4(d) for LAO/STO(001) heterointerfaces of n and p types. From these, one can clearly see that deviation of charges are relatively small in the inner monolayers of the LAO film in n-type LAO/STO(001), not exceeding 0.03e, whereas the same layers in the p-type LAO/STO(001) show quite large charge deviations ±(0.35–0.40)e from the parent bulk, and these are negative for AlO₂ monolayers and positive for LaO monolayers.

In both n- and p-type interfaces, charges on the substrate monolayers did not vary substantially. For stoichiometric n-type and nonstoichiometric p-type interfaces, these are about ±0.04e for TiO₂ and SrO, respectively. On the other hand, stoichiometric p-type interfaces show a small positive deviation of TiO₂ monolayer charges (ca. 0.01e) and about 10 times bigger negative charge deviation for SrO monolayers. Charge shifts in the substrates of stoichiometric n-type structures are all negative, and SrO shifts (ca. 0.04e) are smaller than TiO₂ shifts of ca. 0.06e.

Most significant deviations in atomic charges of n-type structures are located in the top-most monolayer—+0.2e for stoichiometric structures and −0.25e for nonstoichiometric ones—due to the surface effects and, thus, compensate the "polar catastrophe" as proposed from a pure ionic model.59 In p-type structures charge shifts in the surface layers are less pronounced than in the inner layers of the film and are +0.05e and −0.27e for LaO- and AlO₂-terminated structures, respectively. Here charge redistribution only in the thickest structures investigated is shown. Respective graphs for thinner structures can be found in Refs. 60 and 61.

Another way to look at the problem of charge redistribution is to calculate what happens with the electronic charge density in the heterostructures compared to the isolated LAO and STO slab parts. Charge-density redistribution is defined as the electronic density in the heterointerface minus the sum of electron densities in separately isolated STO(001) substrate and LAO(001) thin film slabs and is depicted in Fig. 5 for both n- and p-type LAO/STO(001) interfaces.

These plots show us that the most significant distortions occur at the interface due to the compensation of the surface effects of the slabs. They also show that the electronic structure of the substrate of nonstoichiometric heterostructures is distorted stronger than that of stoichiometric ones. The situation in the thin films is opposite. This fact correlates with the argument in the section on atomic structure.
FIG. 5. (Color online) Difference electron charge-density maps calculated for [(a)–(d)] \( n \)-LAO/STO(001) and [(e)–(h)] \( p \)-LAO/STO(001) heterostructures: [(a) and (e)] (110) cross section for \( N_{\text{LAO}} = 10 \), [(b) and (f)] (100) cross section for \( N_{\text{LAO}} = 10 \), [(c) and (g)] (110) cross section for \( N_{\text{LAO}} = 11 \), and [(d) and (h)] (100) cross section for \( N_{\text{LAO}} = 11 \). Red (dark gray), blue (light gray), and gray isolines describe positive, negative, and zero values of the difference charge density, respectively. Isodensity curves are drawn from \(-0.025 \) to \(+0.025 \) e \( \text{Å}^{-3} \) with an increment of \( 0.0005 \) e \( \text{Å}^{-3} \). Right-side bar shows the atomic monolayers from which atoms are originated. Calculations are performed using a B3PW hybrid exchange-correlation functional. STO and LAO monolayers are numbered beginning from the center of the slab (0 means the central monolayer of the symmetrical slab unit cell). Monolayers (planes) are numbered separately for STO(001) substrate and for LAO(001) nanofilm.

More illustrative property to consider is the polarization of all four of stoichiometric and nonstoichiometric \( n \)- and \( p \)-type heterointerfaces, which was already briefly introduced. It allows us to explain certain phenomena, such as the polar distortion, as well as to provide a mechanism for a partial compensation of the “polar catastrophe.”

Let us assume that each one of considered interfaces possesses no net charge, thus, it can be divided into multiple neutral slabs normal to \( z \), in which net charge is also zero and average polarization of such slabs can be calculated. The charge-density function that should be used in the calculations is estimated as if the charge of each atom \( A \) is uniformly distributed over the plane \( z = z_A \), reducing the task to one dimension. Thus, the projection of polarization vector on \( z \) axis can be calculated as

\[
\bar{P}_z = \frac{\sum_A z_A Q_A}{\Delta z},
\]

where \( Q_A \) is the charge on atom \( A \) and \( \Delta z \) is the thickness of the neutral allocated slab, to which the atom \( A \) belongs and summation is performed over all the atoms in the \( i \)-th neutral slab. In order to divide the interface in neutral slabs, it sometimes is necessary to split one monolayer’s charge: One part of it compensates the remaining charge of the previous slab and the remainder goes to the next one.

The resulting polarization function \( P(z) \) is averaged using the moving average function, and the results for \( n \)- and \( p \)-type interfaces are shown together with the energies of band boundaries \( E_{TVB} \) and \( E_{BCB} \) and the potential due to intrinsic electrostatic field \( V \) in Fig. 6. Here one can see that LAO films of stoichiometric interfaces are strongly polarized, giving rise to the polar distortion of band edges. On the other hand, there is rather weak LAO polarization in the nonstoichiometric interfaces, meaning a weak polar distortion as is observed.

The substrate is polarized more in the nonstoichiometric case, which corresponds to Figs. 5(c) and 5(d) and Figs. 5(g)
and 5(h). AlO$_2$-terminated structures possess substantial polarization in the top-most monolayer. The top-most layer’s polarization of LaO-terminated structures, on the other hand, is negligible. The interface monolayers of n-type structures are substantially polarized.

Electronic properties in a more experimentally measurable way can be represented as band gaps for insulating structures or as the concentration of charge carriers for conductors. These data, obtained with CRYSTAL and VASP, are represented in Tables IV and V for n- and p-type structures, respectively. First, one can see that all the nonstoichiometric interfaces are conducting and the free charge concentration is roughly equal within a type and does not depend on the LAO film thickness. p-Type structures possess greater carrier density than n-type structures, though experiments never showed conductive behavior in the former.

For stoichiometric structures insulating behavior is the default one. The thickness of the band gap decreases with the thickness of the LAO film both for n- and p-type structures. This eventually leads to the closing of the gap for the n-type interfaces with $N_{\text{LAO}} \geq 10$ monolayers, which is in a good accordance with experimental works.$^{11}$ The gap-diminishing tendency is less pronounced for the p-type structures and, thus, they are not found conducting at any thickness within this study.

The results obtained with VASP are given for qualitative comparison. They showed out to be in accordance with CRYSTAL results, but, due to the specifics of the nonhybrid functional, band gaps and free charge concentrations are far too small. Taking into account that the largest difference between that calculated using the CRYSTAL code and the experimentally observed band gap of bulk materials is 0.39 eV (see Table I), we note that our CRYSTAL calculations give plausible results compared to experimental data.

The total band gap described above gives us some valuable data on the conducting-insulating behavior of the interfaces of different types. Nevertheless, it does not give us much information about the origin of conductivity. Thus, it is more worthy to look at the positions of the band edges in energy scale separately for each monolayer. Such a decomposition is depicted in aforementioned Figs. 6(a) and 6(b) and then Figs. 6(c) and 6(d) for n- and p-type structures, respectively. From these plots one can see that band edges for stoichiometric interfaces are distorted; in addition, such a distortion leads to n-type conductivity in n-type structures that are thick enough and might hypothetically lead to the p-type conductivity in thicker p-type structures than investigated. Nonstoichiometric interfaces show little or no polar distortion, but it is not necessary for the appearance of the conductivity, because such interfaces are distorted; in addition, such a distortion leads to n-type conductivity in n-type structures that are thick enough and might hypothetically lead to the p-type conductivity in thicker p-type structures than investigated. Nonstoichiometric interfaces show little or no polar distortion, but it is not necessary for the appearance of the conductivity, because such interfaces are distorted; in addition, such a distortion leads to n-type conductivity in n-type structures that are thick enough and might hypothetically lead to the p-type conductivity in thicker p-type structures than investigated. Nonstoichiometric interfaces show little or no polar distortion, but it is not necessary for the appearance of the conductivity, because such interfaces are distorted; in addition, such a distortion leads to n-type conductivity in n-type structures that are thick enough and might hypothetically lead to the p-type conductivity in thicker p-type structures than investigated. Nonstoichiometric interfaces show little or no polar distortion, but it is not necessary for the appearance of the conductivity, because such interfaces are distorted; in addition, such a distortion leads to n-type conductivity in n-type structures that are thick enough and might hypothetically lead to the p-type conductivity in thicker p-type structures than investigated. Nonstoichiometric interfaces show little or no polar distortion, but it is not necessary for the appearance of the conductivity, because such interfaces are distorted; in addition, such a distortion leads to n-type conductivity in n-type structures that are thick enough and might hypothetically lead to the p-type conductivity in thicker p-type structures than investigated. Nonstoichiometric interfaces show little or no polar distortion, but it is not necessary for the appearance of the conductivity, because such interfaces are distorted; in addition, such a distortion leads to n-type conductivity in n-type structures that are thick enough and might hypothetically lead to the p-type conductivity in thicker p-type structures than investigated. Nonstoichiometric interfaces show little or no polar distortion, but it is not necessary for the appearance of the conductivity, because such interfaces are distorted; in addition, such a distortion leads to n-type conduc...
structures contain nonstoichiometric LAO films, which are already conducting on their own. Our prediction on conductivity of nonstoichiometric LaO-terminated $n$-type LAO/STO(001) interfaces is in agreement with a recent theoretical study performed by Pavlenko and Kopp (see Ref. 62) in which they show that the LaO-terminated $n$-type LAO/STO(001) interface is metallic.

IV. SUMMARY AND CONCLUDING REMARKS

We have performed large-scale first-principles calculations on a number of both stoichiometric and nonstoichiometric LAO/STO(001) heterostructures. Two different $ab$ initio approaches have been applied: LCAO with hybrid B3PW and PW with PW91 exchange-correlation functionals within DFT. Consistently within both approaches, we predict that there exists a distortion in energies of band edges for stoichiometric structures which eventually leads to the appearance of the conductivity at a critical thickness in $n$-type interfaces or to the reduction of the band gap for $p$-type interfaces. Nonstoichiometric interfaces were found to be conducting independently of the LAO film thickness and possessing little or no distortion of band edges. The conductivity appears due to the nonstoichiometry of the thin film which is a conductor on its own, as we demonstrate by a separate analysis of an isolated film.

The degree of distortion of the band edges agree well with the estimates of the internal electric field generated by changes in the atomic charges and the geometric relaxation of the atomic structure. We confirm these factors as the ones responsible for the rise of conductivity in stoichiometric interfaces conducting as nonstoichiometric interfaces grown at temperatures above 550 K. If the LAO/STO(001) heterointerface is covered by a LaO monolayer, charge compensation mechanism of deposited polar nonstoichiometric LAO film leads to the tendency of Ti$^{3+}$ formation at the interface (see Fig. 4). To some extend it may explain the unexpected observation of Ti$^{3+}$ photoemission spectroscopy peak from $n$-type LAO/STO interfaces grown at 873 K.

In general, we conclude that one should not disregard the stoichiometry aspect when considering ways to make the LAO/STO interfaces conducting as nonstoichiometric interfaces possess unique quasi-2D electron gas structure that gives an overall 2 times greater free charge carrier density in comparison with stoichiometric interfaces. For stoichiometric $n$-type structures, the interplay of covalent and electrostatic forces leads to a metal-insulator transition at critical film thickness but, for nonstoichiometric structures, it lead to the formation of a bilayered ($n$-type IFs) or monolayered ($p$-type IFs) quasi-2D electron gas.

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